

Algorithmic randomness test for a class of measures

Péter Gács

Computer Science Department
Boston University

Coverfest

Martin-Löf's theory of randomness

(As presented by Levin). Let X be the space Σ^* of finite strings, or the space Σ^ω of infinite strings. Let μ be a probability measure over X . A **test**

$$f_\mu(x)$$

quantifies the nonrandomness of outcome $x \in X$ with respect to μ . In Martin-Löf's theory, measure μ is assumed to be “**computable**” and **fixed**. Required:

- $\int f_\mu(x) \mu(dx) \leq 1$. (The measure of “non-random” objects is small.)
- f is lower semicomputable in x . (Sooner or later we will recognize non-randomness.)

Test t is **universal** if $\forall f \exists c > 0 \forall x f_\mu(x) < c \cdot t_\mu(x)$.

There is a universal test $\tilde{t}_\mu(x)$.

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Theorem

There is a universal test $\tilde{t}_\mu(x)$.

Test in terms of complexity

I assume familiarity with description (Kolmogorov) complexity. Let $X = \Sigma^*$. For $x \in X$, denote the complexity (the prefix version) of x by

$$H(x)$$

(same as $K(x)$ in [Li-Vitányi](#)). Let $\tilde{d}_\mu(x) = \log \tilde{t}_\mu(x)$, called the *deficiency of randomness* of x with respect to μ .

The following holds, for constants c_μ : Over the set of finite strings,

$$\tilde{d}_\mu(x) \stackrel{\pm}{=} -\log \mu(x) - H(x) + c_\mu.$$

Over the set of infinite strings,

$$\tilde{d}_\mu(x) \stackrel{\pm}{=} \sup_n -\log \mu(x_{\leq n}) - H(x_{\leq n}) + c_\mu.$$

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Arbitrary measures

Restriction to computable measures is unnatural (it is particularly baffling to probabilists). How to extend the definition to arbitrary measures? Idea: just use (over $X = \Sigma^*$):

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Alas, this test has undesirable properties (does not “conserve randomness”).

New idea (following early work of Levin): test $f_\mu(x)$:

- $\int f_\mu(x) \mu(dx) \leq 1$.
- f is lower semicomputable in the pair (μ, x) .

What does this mean? If we mean that μ is defined by an infinite string S with $f_S(x)$, (lower semi)computable from (S, x) then different descriptions of the same S may give different tests.

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Other idea: equip the space of measures with a computability structure, so that one can talk about (lower semi)computability in μ itself, independent of its the particular description. In other words, the dependence on μ must be **extensional**. Levin has done this for infinite binary sequences.

This approach is attractive, but we also leads to some unexpected results (neutral measure).

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Computability extended: instead of only about random strings, to speak of random real numbers, even about a [random path of the Brownian motion](#) (non-compact space). (For the special case of Brownian motion the concept has been worked out already by [Asarin](#).)

Here, I will only work with metric spaces.

Computable metric space

$\mathbf{X} = (X, d, D, \alpha)$.

- A distance function d over X .
- A fixed countable dense set $D \subseteq X$ (so, \mathbf{X} is separable).
- An enumeration α of D .

Condition: $d(x, y)$ is computable for $x, y \in D$.

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Continuity and computability

Some concepts of topology, and their constructive versions:

Basis of open balls: balls with center in the dense set D and rational radius.

Open set: a union of basis elements.

R.e. open set: a union of a r.e. set of basis elements.

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Let $f : X \rightarrow Y$ between metric spaces.

Continuous: $f^{-1}(V)$ is open for all basis elements $V \subseteq Y$.

Computable: $f^{-1}(V)$ is r.e. open, **uniformly** in the enumerated basis elements V .

Lower semicomputable: a constructive version of “lower semicontinuity”: the set

$$\{(x, r) : f(x) > r\}$$

is a r.e. open subset of $X \times \mathbb{Q}$.

Computable point: $x \in X$: if the constant function $0 \mapsto x$ is.

Effective compactness: If for every k one can compute a covering of X by basic balls of radius $\leq 1/k$.

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The following observation is useful, for a computable metric space X :

Proposition

Let $f : \subseteq X \rightarrow \mathbb{R}_+$ be a lower semicomputable function. Then it can be extended to a total lower semicomputable function $g : X \rightarrow \mathbb{R}_+$.

Topology of measures

We will always require \mathbf{X} to be a **complete** computable metric space.

Weak convergence: $\mu_i \rightarrow \mu$ if $\mu_i f \rightarrow \mu f$ for all bounded continuous functions f . Can be metrized using, for example, the Prokhorov distance.

Dense set of measures: finite rational combinations of measures of form δ_x for $x \in D$.

This turns the set of probability measures into a computable complete metric space $\mathbf{M}(\mathbf{X})$.

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Definition (μ -test)

A μ -test is a (possibly partial) function $f_\nu(x)$ with

- $f_\nu(x)$ is lower semicomputable in (ν, x) .
- $\int f_\mu(x)\mu(dx) \leq 1$.

It is a **uniform test** if it is a ν -test for each ν .

Universal uniform test (Levin, 1973)

There is a universal uniform test $t_\mu(x)$: for all μ and each μ -test $f_\mu(x)$ there is a constant c_t such that for all x we have

$$f_\mu(x) < c_t t_\mu(x).$$

Note that the universal uniform test $t_\mu(x)$ dominates even the μ -tests for **fixed** μ .

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Given the universal uniform test $\mathbf{t}_\mu(x)$, there is a natural candidate for a class test:

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Theorem

Assume that the class \mathcal{C} is effectively compact. Then $\mathbf{t}_{\mathcal{C}}(x)$ is a class test and it is universal (dominates all other class tests for \mathcal{C}).

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Martin-Löf's approach

Martin-Löf also defined Bernoulli tests. We give it in the integral-constraint version. Denote

$$\mathbb{B}(n, k) = \{x \in \mathbb{B}^n : \sum_i x(i) = k\}.$$

A combinatorial Bernoulli test is a function $f : \mathbb{B}^* \rightarrow \overline{\mathbb{R}}_+$ with the following constraints:

- It is lower semicomputable.
- It is monotonic with respect to the prefix relation.
- For all $0 \leq k \leq n$ we have $\sum_{x \in \mathbb{B}(n, k)} f(x) \leq 1$.

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There is a universal combinatorial Bernoulli test.

Fix a universal combinatorial Bernoulli test $b(x)$ and extend it to infinite sequences ξ by $b(\xi) = \sup_n b(\xi^{\leq n})$.

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Let $\mathbf{t}_{\mathcal{B}}(\xi)$ be a universal class test for Bernoulli measures, for infinite sequences.

We have $b(\xi) \stackrel{\Delta}{=} \mathbf{t}_{\mathcal{B}}(\xi)$.

In words: a sequence is nonrandom with respect to all Bernoulli measures if and only if it is rejected by a universal combinatorial Bernoulli test; moreover, even the degree of nonrandomness for random sequences, defined in the two ways, is the same.

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Orthogonality

Bernoulli sequences

Let $0 < p < 1$, and $x = x_1x_2\dots$ an infinite sequence, with

$$S_n(x) = x_1 + \dots + x_n.$$

Then x is Bernoulli random with respect to p if

- ① x is random with respect to the class \mathcal{B} of Bernoulli measures.
- ② $S_n(x)/n \rightarrow p$.

Requirement ② (as convergence in general) can be replaced with a stronger one, say:

- $|S_n(x)/n - p| < n^{-1/3}$ for all but finitely many n .

We want to generalize this observation.

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Separating test

Definition

For a class \mathcal{C} of measures over a computable metric space $\mathbf{X} = (X, d, D, \alpha)$, a lower semicomputable function $s : X \times \mathcal{C} \rightarrow \overline{\mathbb{R}}_+$ is a **separating test** for a subclass $\mathcal{C}' \subseteq \mathcal{C}$ if

- $s_\mu(\cdot)$ is a test for each $\mu \in \mathcal{C}$.
- if μ or $\mu' \in \mathcal{C}'$ and $\mu \neq \nu$ then $s_\mu(x) \vee s_\nu(x) = \infty$ for all $x \in X$.

We call an element x **typical** for $\mu \in \mathcal{C}'$ if $s_\mu(x) < \infty$.

A typical element determines uniquely the measure μ for which it is typical.

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Example

For a binary sequence x , and for $p \in [0, 1]$ the function

$$s_p(x) = s_{B_p}(x) = c \cdot \sup\{k : |S_{2^k}(x) - 2^k p| > 2^{0.6k}\}$$

is a separation test for the Bernoulli class \mathcal{B} , for an appropriately chosen constant c .

In creating this test we exploited the existence of a **computable convergence speed** in the law of large numbers.

A generalization of the Bernoulli example:

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\mathcal{C} is the class of m -state stationary Markov chains, \mathcal{C}' the class of ergodic chains.

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When a separating test exists, it helps structuring randomness tests:

Theorem

Let \mathcal{C} be an effectively compact class of measures, let $\mathbf{t}_\mu(x)$ be the universal uniform test and let $\mathbf{t}_\mathcal{C}(x)$ be a universal class test for \mathcal{C} . Assume that $s_\mu(x)$ is a separating test for $\mathcal{C}' \subseteq \mathcal{C}$. Then we have the representation

$$\mathbf{t}_\mu(x) \stackrel{*}{=} \mathbf{t}_\mathcal{C}(x) \vee s_\mu(x)$$

for all $\mu \in \mathcal{C}'$.

The theorem separates the randomness test into two parts. One part tests randomness with respect to the class \mathcal{C} , the other typicality with respect to the measure μ .

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In the Bernoulli example,

- Part $t_{\mathcal{G}}(x)$ checks “Bernoulliness”, that is independence. It encompasses all the irregularity criteria.
- Part $s_p(x)$ checks (crudely) for the law of large numbers: whether relative frequency converges (fast) to p .

If the independence of the sequence is taken for granted, we may assume that the class test is satisfied. What remains is typicality testing, similar to ordinary statistical parameter testing.

Separation is the only requirement of the test $s_\mu(x)$, otherwise, for example in the Bernoulli test case, no matter how crude the convergence criterion expressed by $s_\mu(x)$, the maximum $t_{\mathcal{G}}(x) \vee s_\mu(x)$ is always (essentially) the same universal test.

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Stationary processes

Much more complicated case: arbitrary stationary processes (say 0-1 valued).

The separating test that we gave for the Bernoulli measures (and can be given for the above simple Markov chains) makes use of a known speed of convergence in the law of large numbers.

V'yugin proved that for arbitrary stationary processes, no recursive speed of convergence can be guaranteed in the Ergodic Theorem (which is the appropriate generalization of the law of large numbers).

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Question

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Desireable test properties

Randomness with respect to computable measures has certain—intuitively meaningful—**monotonicity**:

- $\mu \leq \nu \Rightarrow$ if x is random with respect to μ it is random with respect to ν .

This property does not survive for the uniform test.

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Neutral measure

If S is a sequence describing μ , and a test $t_S(x)$ is computed as a function of the sequence S (**intensional**, or “via oracle S ” as opposed to our **extensional** definition) then one can compute from S an object x with $\mu(\{x\}) = 0$, so there is a nonrandom object for μ . But if we require (as we did) tests to be intensional in μ then this is not true anymore:

If X is compact then there is a measure M with the property that for all x , $t_M(x) \leq 1$.

Levin called this measure “apriori probability”, I use the more neutral term **neutral measure**.

For our test definition, this measure will not have nice computability properties.

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Theorem

Let $f : X \rightarrow Y$ be computable. Then

$$\mathbf{t}_{f^*\mu}(f(x)) \leq^* \mathbf{t}_\mu(x).$$

There is a more general theorem, for computable **random transitions**.

The extensional nature of the test makes it hard to relate it to description complexity, in the case of noncomputable measures. Here, more research is needed.

$$H_\nu(x) = -\log \mathbf{t}_\nu(x)$$

is a generalization of complexity (algorithmic entropy). Indeed, generalizing to non-probability measures ν (example: the **counting measure #**)

$$H_\#(x) \stackrel{+}{=} H(x).$$

This is in analogy to the definition of relative (information-theoretical) entropy of μ with respect to ν ,

$$\mathcal{H}_\nu(\mu) = - \int \log \frac{d\mu}{d\nu} d\mu,$$

(which is the negative of the so-called Kullback distance). Special cases: $\nu = \#$ gives ordinary entropy. For $\nu =$ Lebesgue measure gives $-\int f(x) \log f(x) dx$.

Addition theorem

Let us generalize the well-known addition theorem

$$H(x,y) \stackrel{+}{=} H(x) + H(y | x, H(x)).$$

Theorem (General Addition)

$$H_{\mu \times \nu}(x,y) \stackrel{+}{=} H_{\mu}(x | \nu) + H_{\nu}(y | x, H_{\mu}(x | \nu), \mu).$$

The proof is somewhat subtle.

Question

Applications?

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